# Power MOSFET and Schottky Diode

## -20 V, -4.0 Å, Single P-Channel & Schottky Barrier Diode, ESD

#### **Features**

- WDFN 2x2 mm Package with Exposed Drain Pads for Excellent Thermal Conduction
- Lowest R<sub>DS(on)</sub> Solution in 2x2 mm Package
- Footprint Same as SC-88 Package
- Low Profile (< 0.8 mm) for Easy Fit in Thin Environments
- ESD Protected
- High Current Schottky Diode: 2 A Current Rating
- This is a Pb-Free Device

## **Applications**

- Optimized for Battery and Load Management Applications in Portable Equipment
- Li-Ion Battery Charging and Protection Circuits
- DC-DC Buck Circuit

## **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Paran	Parameter			Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	-20	V
Gate-to-Source Voltage	je		$V_{GS}$	±8.0	V
Continuous Drain	Steady	T <sub>A</sub> = 25°C	I <sub>D</sub>	-3.2	Α
Current (Note 1)	State	T <sub>A</sub> = 85°C		-2.3	
	t ≤ 5 s	T <sub>A</sub> = 25°C		-4.0	
Power Dissipation (Note 1)	Steady State	T <sub>A</sub> = 25°C	P <sub>D</sub>	1.5	W
	t ≤ 5 s			2.3	
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	-2.2	Α
Current (Note 2)	Steady	T <sub>A</sub> = 85°C		-1.6	
Power Dissipation (Note 2)	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	0.71	W
Pulsed Drain Current	t <sub>p</sub> =	10 μs	I <sub>DM</sub>	-16	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	–55 to 150	°C
Source Current (Body Diode) (Note 2)			I <sub>S</sub>	-1.0	Α
Lead Temperature for S (1/8" from case for 10 s		urposes	TL	260	°C

### SCHOTTKY MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Parameter	Symbol	Value	Unit
Peak Repetitive Reverse Voltage	$V_{RRM}$	30	V
DC Blocking Voltage	$V_R$	30	V
Average Rectified Forward Current	IF	2.0	Α

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
- Surface Mounted on FR4 Board using the minimum recommended pad size, (30 mm², 2 oz Cu).



## ON Semiconductor®

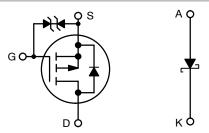
#### www.onsemi.com

#### P-CHANNEL MOSFET

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> Max	I <sub>D</sub> Max
	100 mΩ @ -4.5 V	
-20 V	144 mΩ @ –2.5 V	-4.0 A
	200 mΩ @ -1.8 V	

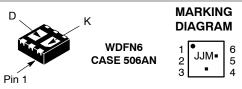
## SCHOTTKY DIODE

V <sub>R</sub> Max	V <sub>F</sub> Max	I <sub>F</sub> Max
20 V	0.47 V	2.0 A



P-CHANNEL MOSFET

SCHOTTKY DIODE

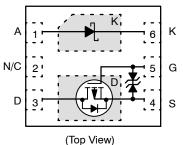


JJ = Specific Device Code

M = Date Code ■ = Pb-Free Package

(Note: Microdot may be in either location)

#### PIN CONNECTIONS



## **ORDERING INFORMATION**

See detailed ordering and shipping information on page 3 of this data sheet.

### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 3)	$R_{ hetaJA}$	83	
Junction-to-Ambient - Steady State Min Pad (Note 4)	$R_{ hetaJA}$	177	°C/W
Junction-to-Ambient – $t \le 5$ s (Note 3)	$R_{ hetaJA}$	54	

- Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
   Surface Mounted on FR4 Board using the minimum recommended pad size (30 mm², 2 oz Cu).

## MOSFET ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Test Condition	ıs	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = -25$	50 μΑ	-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	I <sub>D</sub> = -250 μA, Ref to	25°C		13		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = -16 V, V <sub>GS</sub> = 0 V	T <sub>J</sub> = 25°C			-1.0	μΑ
			1J = 85°C			-10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V$ , $V_{GS} = \pm$	8.0 V			±10	μΑ
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$ , $I_D = -2$	50 μΑ	-0.4		-1.0	V
Gate Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				2.0		mV/°C
Drain-to-Source On-Resistance	R <sub>DS(on)</sub>	$V_{GS} = -4.5 \text{ V}, I_D = -4.5 \text{ V}$	-2.0 A		68	100	mΩ
	. ,	$V_{GS} = -2.5 \text{ V}, I_D = -2.5 \text{ V}$	-2.0 A		90	144	1
		$V_{GS} = -1.8 \text{ V}, I_D = -1.8 \text{ V}$	-1.7 A		125	200	1
Forward Transconductance	9 <sub>FS</sub>	$V_{DS} = -16 \text{ V}, I_{D} = -$	-2.0 A		6.5		S
CHARGES, CAPACITANCES AND GA	TE RESISTAN	CE			•		•
Input Capacitance	C <sub>ISS</sub>	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = -10 \text{ V}$			450		pF
Output Capacitance	C <sub>OSS</sub>				90		7
Reverse Transfer Capacitance	C <sub>RSS</sub>				62		1
Total Gate Charge	Q <sub>G(TOT)</sub>				5.2	7.8	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DS} =$	–10 V,		0.3		1
Gate-to-Source Charge	$Q_{GS}$	$V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V},$ $I_D = -2.0 \text{ A}$			0.84		1
Gate-to-Drain Charge	$Q_{GD}$				1.5		1
SWITCHING CHARACTERISTICS (No	te 6)						
Turn-On Delay Time	t <sub>d(ON)</sub>				6.6		ns
Rise Time	t <sub>r</sub>	$V_{GS} = -4.5 \text{ V}, V_{DD} =$	–5.0 V,		9.0		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DD} = I_D = -2.0 \text{ A}, R_G = 2.0 \text{ A}$	2.0 Ω		14		1
Fall Time	t <sub>f</sub>				12.5		1
DRAIN-SOURCE DIODE CHARACTE	RISTICS				-		-
Forward Recovery Voltage	$V_{SD}$	\\	T <sub>J</sub> = 25°C		-0.73	-1.0	
		$V_{GS} = 0 \text{ V}, I_{S} = -1.0 \text{ A}$	T <sub>J</sub> = 125°C		-0.62		\ \
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS}$ = 0 V, $d_{ISD}/d_t$ = 100 A/ $\mu$ s, $I_S$ = -1.0 A			23		
Charge Time	ta				13		ns
Discharge Time	t <sub>b</sub>				10		1
Reverse Recovery Time	Q <sub>RR</sub>				10		nC

- 5. Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2%.
  6. Switching characteristics are independent of operating junction temperatures.

## $\textbf{SCHOTTKY DIODE ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}\text{C unless otherwise noted})$

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
Maximum Instantaneous	V <sub>F</sub>	I <sub>F</sub> = 100 mA		0.34	0.39	V
Forward Voltage		I <sub>F</sub> = 1.0 A		0.47	0.53	
Maximum Instantaneous	I <sub>R</sub>	V <sub>R</sub> = 30 V		17	20	μΑ
Reverse Current		V <sub>R</sub> = 20 V		3.0	8.0	
		V <sub>R</sub> = 10 V		2.0	4.5	
Capacitance	С	V <sub>R</sub> = 5.0 V, f = 1.0 MHz		38		pF

## $\textbf{SCHOTTKY DIODE ELECTRICAL CHARACTERISTICS} \ (T_J = 85^{\circ}C \ unless \ otherwise \ noted)$

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
Maximum Instantaneous	V <sub>F</sub>	I <sub>F</sub> = 100 mA		0.22	0.35	V
Forward Voltage		I <sub>F</sub> = 1.0 A		0.40	0.50	
Maximum Instantaneous	I <sub>R</sub>	V <sub>R</sub> = 30 V		0.22	2.5	mA
Reverse Current		V <sub>R</sub> = 20 V		0.11	1.6	
		V <sub>R</sub> = 10 V		0.06	1.2	

## SCHOTTKY DIODE ELECTRICAL CHARACTERISTICS ( $T_J = 125^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
Maximum Instantaneous	V <sub>F</sub>	I <sub>F</sub> = 100 mA		0.20	0.29	V
Forward Voltage		I <sub>F</sub> = 1.0 A		0.40	0.47	
Maximum Instantaneous	I <sub>R</sub>	V <sub>R</sub> = 30 V		2.0	20	mA
Reverse Current		V <sub>R</sub> = 20 V		1.1	10.9	
		V <sub>R</sub> = 10 V		0.63	8.4	

## **ORDERING INFORMATION**

Device Order Number	Package Type	Tape & Reel Size†
NTLJD3182FZTAG	WDFN6 (Pb-Free)	3000 / Tape & Reel
NTLJD3182FZTBG	WDFN6 (Pb-Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

## TYPICAL PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)

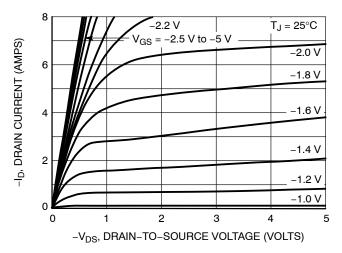


Figure 1. On-Region Characteristics

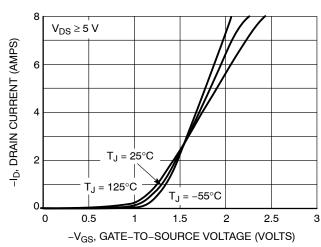


Figure 2. Transfer Characteristics

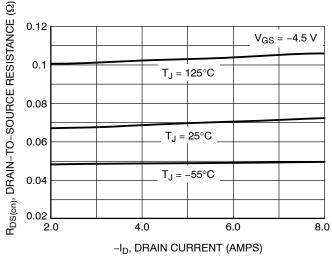


Figure 3. On-Resistance versus Drain Current

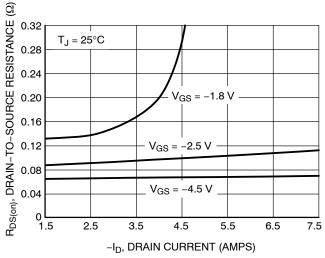


Figure 4. On-Resistance versus Drain Current and Gate Voltage

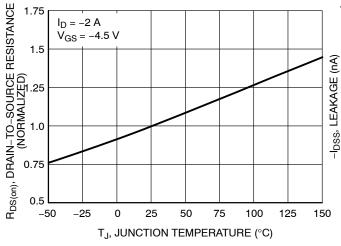


Figure 5. On–Resistance Variation with Temperature

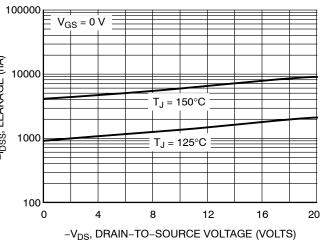


Figure 6. Drain-to-Source Leakage Current versus Voltage

## TYPICAL PERFORMANCE CURVES ( $T_J = 25^{\circ}C$ unless otherwise noted)

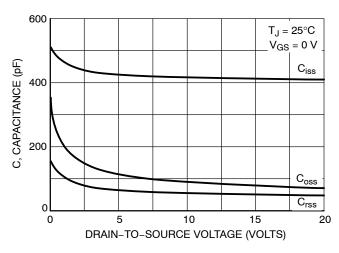


Figure 7. Capacitance Variation

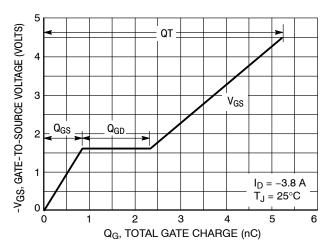


Figure 8. Gate-To-Source and Drain-To-Source Voltage versus Total Charge

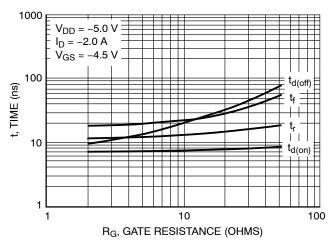


Figure 9. Resistive Switching Time Variation versus Gate Resistance

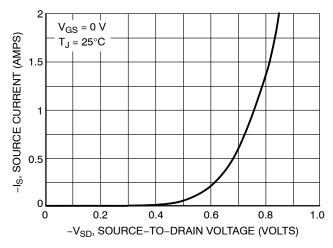


Figure 10. Diode Forward Voltage versus Current

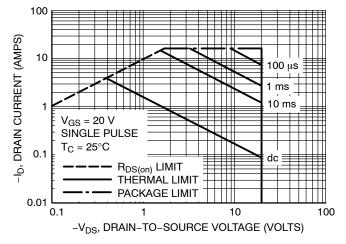


Figure 11. Maximum Rated Forward Biased Safe Operating Area

## TYPICAL PERFORMANCE CURVES ( $T_J = 25^{\circ}$ C unless otherwise noted)

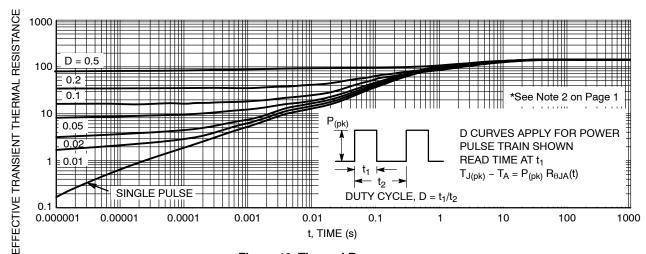
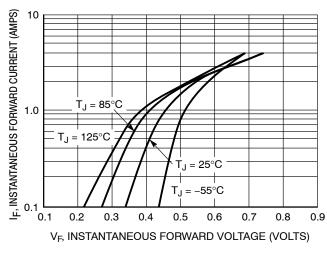


Figure 12. Thermal Response

## TYPICAL SCHOTTKY PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)



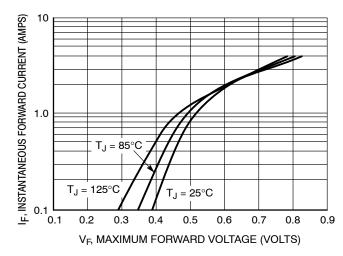


Figure 13. Typical Forward Voltage

Figure 14. Maximum Forward Voltage

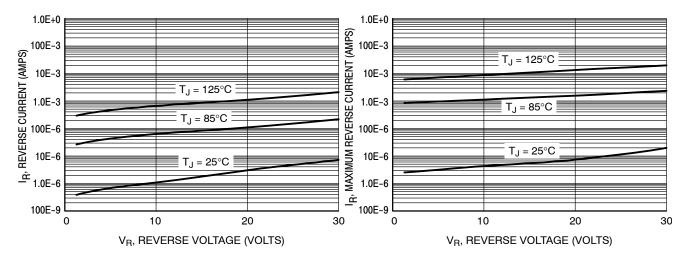
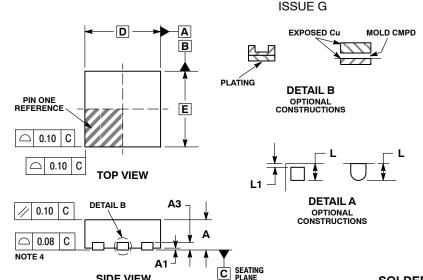


Figure 15. Typical Reverse Current

Figure 16. Maximum Reverse Current

#### PACKAGE DIMENSIONS

## WDFN6 2x2, 0.65P CASE 506AN



⊕ | 0.10 | C | A | B

0.10 С Α В

0.05 С NOTE 3

Ф

⊕ | 0.10 | C | A |

SIDE VIEW

**BOTTOM VIEW** 

D<sub>2</sub>

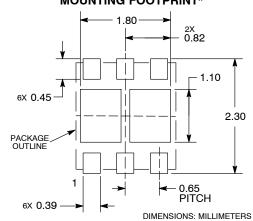
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DETAIL

- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION & APPLIES TO PLATED
  TERMINAL AND IS MEASURED BETWEEN
- 0.15 AND 0.30 mm FROM THE TERMINAL TIP.
  COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIMETERS				
DIM	MIN	MAX			
Α	0.70	0.80			
A1	0.00 0.05				
A3	0.20 REF				
b	0.25	0.35			
D	2.00 BSC				
D2	0.57 0.7				
E	2.00	BSC			
E2	0.90 1.10				
е	0.65	BSC			
F	0.95 BSC				
K	0.25 REF				
L	0.20 0.30				
L1	0.10				

## **SOLDERMASK DEFINED MOUNTING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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